

Search Notes**Application/Control No.**

10/781,461

Examiner

Betsy L. Deppe

Applicant(s)/Patent under Reexamination

WEI ET AL.

Art Unit

2611

SEARCHED

Class	Subclass	Date	Examiner
375	147	7/30/2007	BD
375	316	7/30/2007	BD
375	340	7/30/2007	BD
370	320	7/30/2007	BD
370	335	7/30/2007	BD
370	342	7/30/2007	BD
370	441	7/30/2007	BD
370	479	7/30/2007	BD
455	561	7/30/2007	BD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Reviewed PLUS search results	7/30/2007	BD
Inventor name search	7/30/2007	BD
Text search (USPAT; USPG-PUB)	7/30/2007	BD
Text search (USPAT; USPG-PUB; EPO; JPO; DERWENT; IBM_TDB)	8/1/2007	BD